Application/Control No. Applicant(s)/Patent Under Reexamination 10/623,569 MIYANO ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Anish Desai 1771 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-6,180,228 01-2001 Mueller et al. 428/354 Α US-В US-С US-D US-E US-F US-G US-Н US-US-J Κ US-US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧

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